## **TOSHIBA**

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type ( $\pi$ -MOSV)

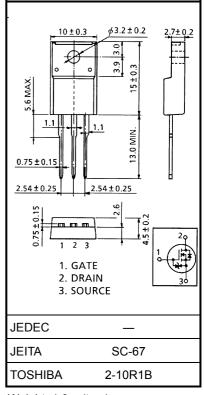
# 2SK2965

Switching Regulator, DC–DC Converter and Motor Drive Applications

- Low drain-source ON resistance  $RDS (ON) = 0.15 \Omega (typ.)$
- High forward transfer admittance  $|Y_{fs}| = 10 \text{ S (typ.)}$
- Low leakage current  $: I_{DSS} = 100 \ \mu A \ (max) \ (V_{DS} = 200 \ V)$
- Enhancement-mode  $: V_{th} = 1.5 \sim 3.5 \text{ V} (V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA})$

### Maximum Ratings (Ta = 25°C)

Characteri	stics	Symbol	Rating	Unit	
Drain-source voltage		V <sub>DSS</sub>	200	V	
Drain-gate voltage (Re	<sub>GS</sub> = 20 kΩ)	V <sub>DGR</sub>	200	V	
Gate-source voltage		V <sub>GSS</sub>	±20	V	
Drain current	DC (Note 1)	I <sub>D</sub>	11	А	
	Pulse (Note 1)	I <sub>DP</sub>	33	А	
Drain power dissipatio	n (Tc = 25°C)	PD	35	W	
Single pulse avalanche	e energy (Note 2)	E <sub>AS</sub>	115	mJ	
Avalanche current		I <sub>AR</sub>	11	А	
Repetitive avalanche e	energy (Note 3)	E <sub>AR</sub>	3.5	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature ra	ange	T <sub>stg</sub>	-55~150	°C	



Weight: 1.9 g (typ.)

#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch–c)</sub>	3.57	°C / W
Thermal resistance, channel to ambient	R <sub>th (ch–a)</sub>	62.5	°C / W

Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2: V\_DD = 50 V, T\_ch = 25°C (initial), L = 1.53 mH, R\_G = 25  $\Omega$ , I\_AR = 11 A

Note 3: Repetitive rating; Pulse width limited by maximum channel temperature.

This transistor is an electrostatic sensitive device. Please handle with caution. Unit: mm

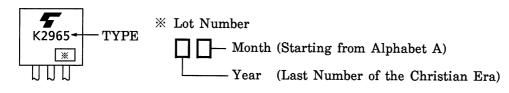
Electrical Characteristics (Ta = 25°C)

Charao	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	skage current $I_{GSS}$ $V_{GS}$ = ±16 V, $V_{DS}$ = 0 V			_	±10	μA	
Drain cut–off cu	rrent	I <sub>DSS</sub>	V <sub>DS</sub> = 200 V, V <sub>GS</sub> = 0 V	_	_	100	μA
Drain-source br	eakdown voltage	V (BR) DSS	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	200	_		V
Gate threshold	voltage	V <sub>th</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.5	_	3.5	V
Drain-source O	N resistance	R <sub>DS (ON)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5.5 A	_	0.15	0.26	Ω
Forward transfe	r admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 5.5 A	5.0	10	_	S
Input capacitance	ce	C <sub>iss</sub>			1200		
Reverse transfer capacitance		C <sub>rss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	100	_	pF
Output capacitance		Coss			290		
Switching time	Rise time	tr	$V_{GS} \stackrel{10V}{}_{0V} \int I_{D} = 5.5A$ $V_{OUT} = V_{OUT} = 18\Omega$ $V_{DD} = 100V = 100V$	_	15	_	
	Turn–on time	t <sub>on</sub>		-	25	_	20
	Fall time	t <sub>f</sub>		_	10	_	- ns
	Turn–off time	t <sub>off</sub>	Duty $\leq 1\%$ , t <sub>w</sub> =10µs	_	75	_	
Total gate charge (gate–source plus gate–drain)		Qg	V <sub>DD</sub> ≈ 100 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A		30	_	nC
Gate-source charge		Q <sub>gs</sub>			20	_	
Gate-drain ("miller") Charge		Q <sub>gd</sub>			10	_	

#### Source–Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	_	_	_	11	А
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>	_	_	_	33	A
Forward voltage (diode)	V <sub>DSF</sub>	I <sub>DR</sub> = 11 A, V <sub>GS</sub> = 0 V	_	—	-2.0	V
Reverse recovery time	t <sub>rr</sub>	I <sub>DR</sub> = 11 A, V <sub>GS</sub> = 0 V, I <sub>DR</sub> / dt = 100 A / μs		175	_	ns
Reverse recovery charge	Q <sub>rr</sub>			1.3	-	μC

#### Marking



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